

February 2008

# FDMC4435BZ

# P-Channel Power Trench<sup>®</sup> MOSFET -30V, -18A, 20.0m $\Omega$

#### **Features**

- Max  $r_{DS(on)} = 20.0 \text{m}\Omega$  at  $V_{GS} = -10 \text{V}$ ,  $I_D = -8.5 \text{A}$
- Max  $r_{DS(on)}$  = 37.0m $\Omega$  at  $V_{GS}$  = -4.5V,  $I_D$  = -6.3A
- Extended V<sub>GSS</sub> range (-25V) for battery applications
- High performance trench technology for extremely low r<sub>DS(on)</sub>
- High power and current handling capability
- HBM ESD protection level >7kV typical (Note 4)
- 100% UIL Tested
- Termination is Lead-free and RoHS Compliant

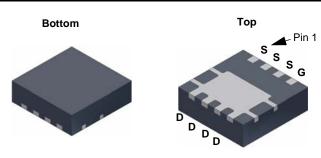
# General Description

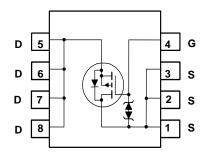
This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This devie is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

#### **Applications**

- High side in DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook







Power 33

### **MOSFET Maximum Ratings** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage			-30	V
$V_{GS}$	Gate to Source Voltage			±25	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25°C		-18	
I <sub>D</sub>	-Continuous (Silicon limited)	T <sub>C</sub> = 25°C		-31	
	-Continuous	T <sub>A</sub> = 25°C	(Note 1a)	-8.5	A
	-Pulsed			-50	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	24	mJ
D	Power Dissipation	T <sub>C</sub> = 25°C		31	W
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1a)	2.3	- VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	4	°C/M
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a	53	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC4435BZ	FDMC4435BZ	Power 33	13"	12mm	3000 units

Units

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted

**Parameter** 

Off Char	acteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$ , referenced to 25°C		22		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -24V,$ $V_{GS} = 0V,$ $T_{J} = 125^{\circ}C$			-1 -100	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 25V$ , $V_{DS} = 0V$			±10	μΑ

**Test Conditions** 

Min

Тур

Max

#### **On Characteristics**

Symbol

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-1.0	-1.9	-3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = -250μA, referenced to 25°C		-5.3		mV/°C
		$V_{GS} = -10V, I_D = -8.5A$		14.6	20.0	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = -4.5V, I_D = -6.3A$		23.1	37.0	mΩ
	$V_{GS} = -10V$ , $I_D = -8.5A$ , $T_J = 125$ °C		20.7	28.0		
9 <sub>FS</sub>	Forward Transconductance	$V_{DD} = -5V, I_D = -8.5A$		24		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	45)/ )/ 0)/	1540	2045	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = -15V, V_{GS} = 0V,$ f = 1MHz	295	395	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 – 1101112	260	385	pF
$R_q$	Gate Resistance	f = 1MHz	5.1		Ω

#### **Switching Characteristics**

	•						
t <sub>d(on)</sub>	Turn-On Delay Time		$V_{DD} = -15V, I_{D} = -8.5A,$ $V_{GS} = -10V, R_{GEN} = 6\Omega$		10	20	ns
t <sub>r</sub>	Rise Time	$V_{DD} = -15V, I_D = -8.5$			6	12	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	v <sub>GS</sub> = -100, k <sub>GEN</sub> =			34	55	ns
t <sub>f</sub>	Fall Time				20	36	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> =0V to -10V			33	46	nC
$Q_{g}$	Total Gate Charge	$V_{GS} = 0V \text{ to } -4.5V$	$V_{DD} = -15V,$		17	24	nC
$Q_{gs}$	Gate to Source Charge		$I_D = -8.5A$		5		nC
$Q_{gd}$	Gate to Drain "Miller" Charge				9		nC

#### **Drain-Source Diode Characteristics**

V <sub>SD</sub> Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = -8.5A$ (Note 2)	)	0.92	1.5	\/	
V <sub>SD</sub>	Source to Drain Diode Forward voltage	$V_{GS} = 0V, I_S = -1.9A$ (Note 2)	)	0.75	1.2	v
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = -8.5A, di/dt = 100A/μs		22		ns
Q <sub>rr</sub>	Reverse Recovery Charge	TF = -0.5A, α//αι = 100A/μS		11		nC

<sup>1:</sup> R<sub>8JA</sub> is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>8JC</sub> is guaranteed by design while R<sub>8CA</sub> is determined by the user's board design.



a. 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

- 2: Pulse Test: Pulse Width <  $300\mu s$ , Duty cycle < 2.0%.
- 3. Starting  $T_J$  = 25°C, L = 1mH,  $I_{AS}$  = -7A,  $V_{DD}$  = -27V,  $V_{GS}$  = -10V.
- 4. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

# **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

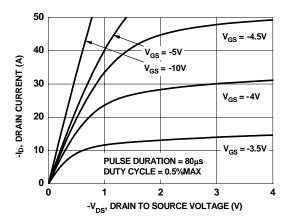


Figure 1. On-Region Characteristics

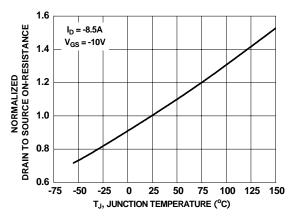


Figure 3. Normalized On-Resistance vs Junction Temperature

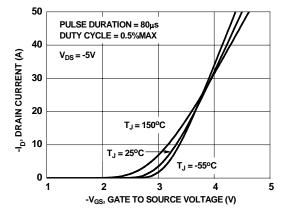


Figure 5. Transfer Characteristics

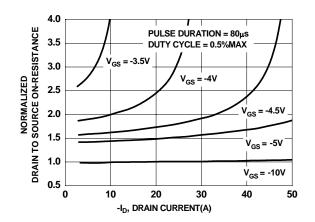


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

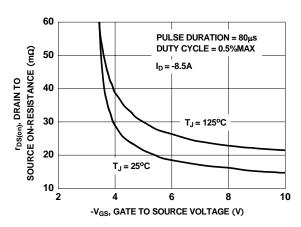


Figure 4. On-Resistance vs Gate to Source Voltage

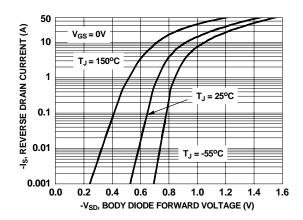


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

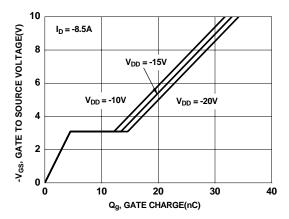


Figure 7. Gate Charge Characteristics

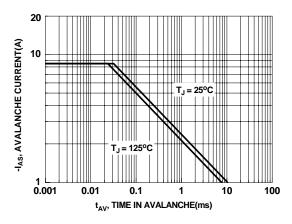


Figure 9. Unclamped Inductive Switching Capability

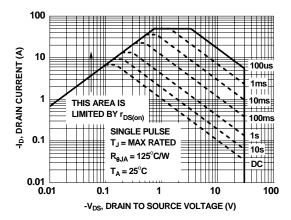


Figure 11. Forward Bias Safe Operating Area

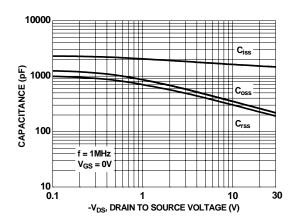


Figure 8. Capacitance vs Drain to Source Voltage

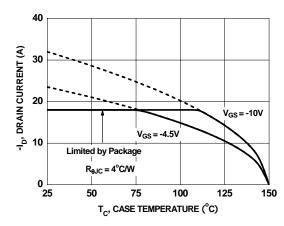


Figure 10. Maximum Continuous Drain Current vs Case Temperature

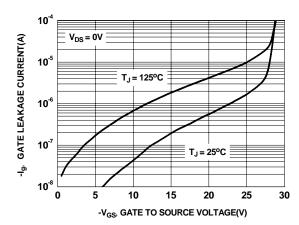


Figure 12. Igss vs Vgss

# Typical Characteristics $T_J = 25^{\circ}\text{C}$ unless otherwise noted

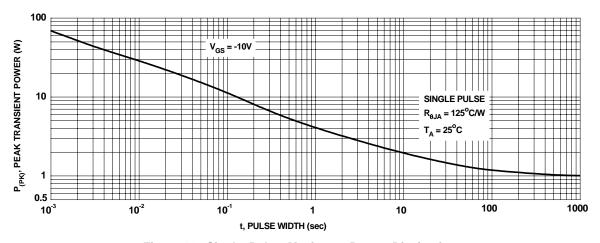


Figure 13. Single Pulse Maximum Power Dissipation

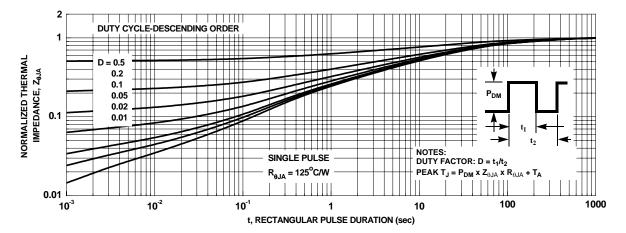
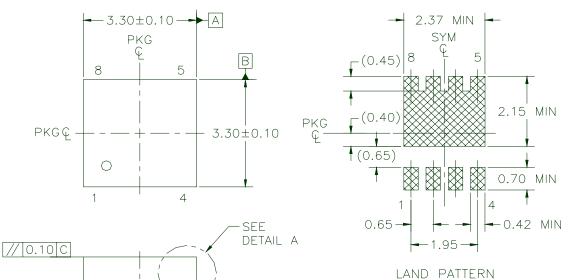
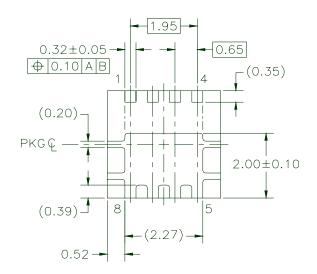


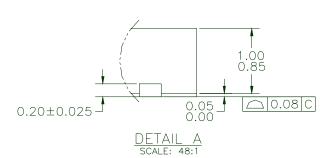
Figure 14. Transient Thermal Response Curve

# **Dimensional Outline and Pad Layout**

C







PQFN08BREV1

NOTES: UNLESS OTHERWISE SPECIFIED

- PACKAGE STANDARD REFERENCE: JEDEC MO229, ISSUE B, VEEC, DATED NOVEMBER 2001.

RECOMMENDATION

- ALL DIMENSIONS ARE IN MILLIMETERS.
  DIMENSIONS DO NOT INCLUDE BURRS
  OR MOLD FLASH.
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.





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